## Back-traced deductive-parallel fault simulation for digital systems

Hahanov, Vladimir; **Ubar, Raimund-Johannes**; Hyduke, Stanley Proceedings : Euromicro Symposium on Digital System Design : Belek-Antalya, Turkey, September 1st to 6th, 2003 2003 / p. 370-377 : ill <u>https://ieeexplore.ieee.org/document/1231969</u>

## Second IEEE East-West Design and Test Workshop

Hahanov, Vladimir; Ubar, Raimund-Johannes IEEE journal of design & test of computers 2004 / p. 594